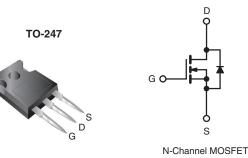


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.27			
Q _g (Max.) (nC)	120				
Q _{gs} (nC)	32				
Q _{gd} (nC)	49				
Configuration	Single				



FEATURES

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Isolated Central Mounting Hole
- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Lead (Pb)-free Available

DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP460LCPbF
	SiHFP460LC-E3
SnPb	IRFP460LC
	SiHFP460LC

ABSOLUTE MAXIMUM RATINGS $T_C = 25 ^{\circ}C$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30	v	
Continuous Drain Current	V_{GS} at 10 V	T _C = 25 °C	- I _D	20		
		T _C = 100 °C		12	A	
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	960	mJ	
Repetitive Avalanche Current ^a			I _{AR} 20		A	
Repetitive Avalanche Energy ^a			E _{AR}	28	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D 280		W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		-	300 ^d	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 4.3 mH, $R_G = 25 \Omega$, $I_{AS} = 20 \text{ A}$ (see fig. 12). c. $I_{SD} \le 20 \text{ A}$, dI/dt $\le 160 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



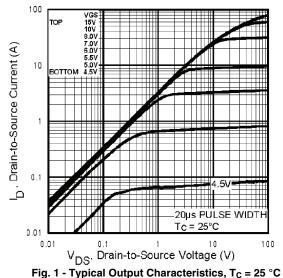


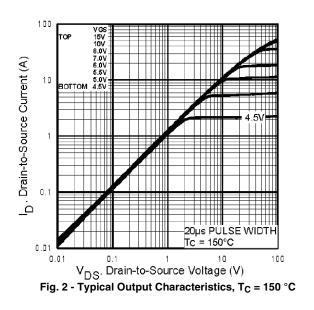
THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		-				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24 -			°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.45	1			
SPECIFICATIONS $T_J = 25 °C$,	unless other	wise noted						
PARAMETER	SYMBOL		CONDITIO	NS	MIN.	TYP.	MAX.	UNIT
Static					<u> </u>			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0	0 V, I _D = 25	0 μΑ	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _C) = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	/ _{GS} , I _D = 25	0 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	$V_{GS} = \pm 20 \text{ V}$			-	± 100	nA
	V _{DS} = 500 V, V _{GS} = 0 V	= 0 V	-	-	25	μA		
Zero Gate Voltage Drain Current		Г _Ј = 125 °С	-	-	250			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 12 A ^b	-	-	0.27	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 1	2 A ^b	12	-	-	S
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	3600	-	pF	
Output Capacitance	C _{oss}			-	440	-		
Reverse Transfer Capacitance	C _{rss}	f = 1.0	f = 1.0 MHz, see fig. 5		-	39	-	1
Total Gate Charge	Qg			= 20 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	120	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V			-	-	32	
Gate-Drain Charge	Q _{gd}	1	see fig. 6 and 13°		-	-	49	
Turn-On Delay Time	t _{d(on)}				-	18	-	
Rise Time	t _r	- V_D = 2	250 V, I _D = 1	20 A	-	77	-	1
Turn-Off Delay Time	t _{d(off)}		$R_{G} = 4.3 \Omega, R_{D} = 12 \Omega, \text{ see fig. } 10^{b}$		-	40	-	ns
Fall Time	tf	1	-			43	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	5.0	-	nH	
Internal Source Inductance	L _S	package and center of die contact			-	13		-
Drain-Source Body Diode Characteristic	cs					-	-	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the		-	-	20	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		80
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^\circ C, \ I_S = 20 \ A, \ V_{GS} = 0 \ V^b$			-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 20 A, dI/dt = 100 A/µs ^b		-	570	860	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	6.6	9.9	μC	
Forward Turn-On Time	t _{on}	Intrinsic turr	n-on time is	negligible (turn	on is dor	minated b	$y L_S$ and	L _D)

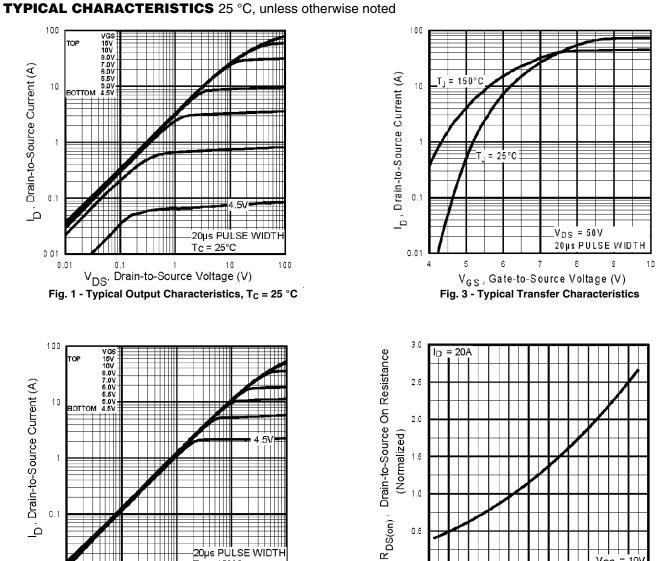
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μs ; duty cycle \leq 2 %.









1.5

1.0

0.5

0.0

-60 -40

-20 0



VGS

20 40 60 80 100 120 140 160

10\

IRFP460LC, SiHFP460LC

Vishay Siliconix

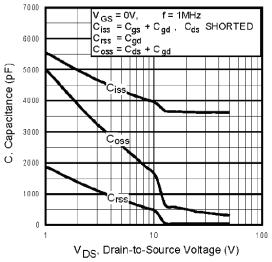


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

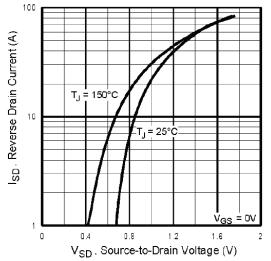


Fig. 7 - Typical Source-Drain Diode Forward Voltage

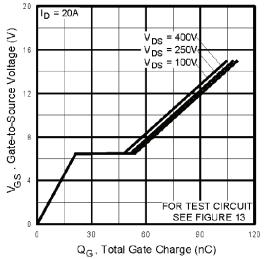


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

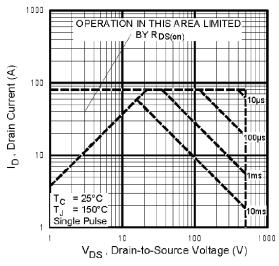


Fig. 8 - Maximum Safe Operating Area

VISHAY.



IRFP460LC, SiHFP460LC

Vishay Siliconix

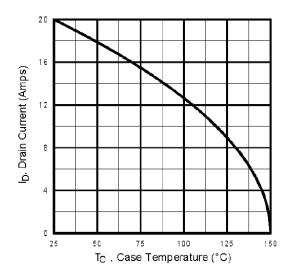


Fig. 9 - Maximum Drain Current vs. Case Temperature

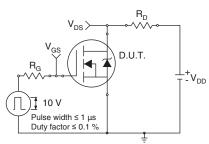


Fig. 10a - Switching Time Test Circuit

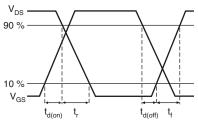


Fig. 10b - Switching Time Waveforms

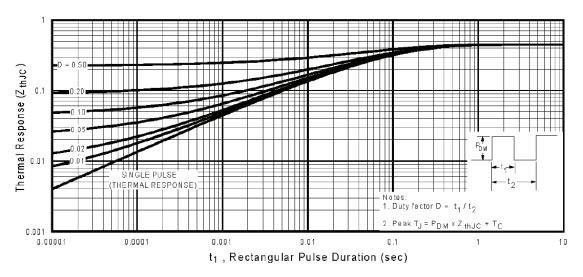


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

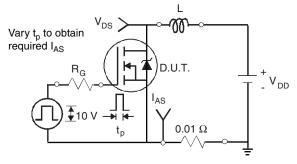


Fig. 12a - Unclamped Inductive Test Circuit

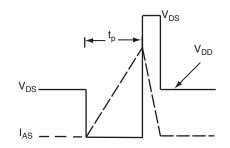


Fig. 12b - Unclamped Inductive Waveforms

IRFP460LC, SiHFP460LC

Vishay Siliconix



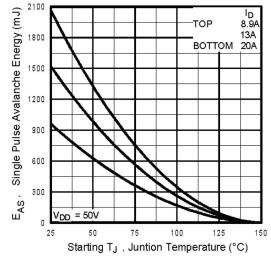


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

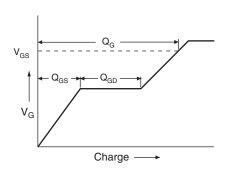


Fig. 13a - Basic Gate Charge Waveform

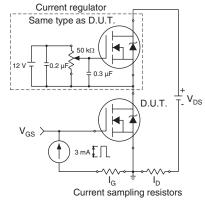
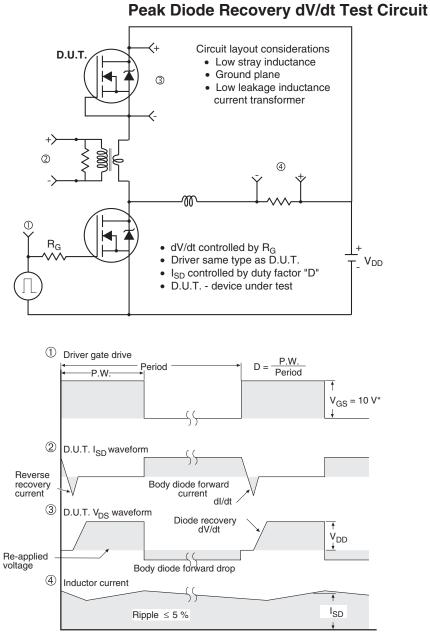


Fig. 13b - Gate Charge Test Circuit





* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91235.





TO-247AC (High Voltage)

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Contour of slot optional.

 Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.

4. Thermal pad contour optional with dimensions D1 and E1.

5. Lead finish uncontrolled in L1.

6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").

7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.

8. Xian and Mingxin actually photo.





Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Vishay: IRFP460LCPBF IRFP460LC